


<b>Search Notes</b>  	<b>Application/Control No.</b>  10821791	<b>Applicant(s)/Patent Under Reexamination</b>  KODEBOYINA, CHAITANYA
	<b>Examiner</b>  MICHAEL C LAI	<b>Art Unit</b>  2457

SEARCHED			
Class	Subclass	Date	Examiner
709	238-244	6/11/2008	Lai
Inventor search		6/11/2008	Lai

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (text search)	6/11/2008	Lai
Consulted Kim Huynh for 101 issue	6/12/2008	Lai
Consulted Moustafa Meky for final action	4/1/2009	Lai
EAST (text search)	3/30/2009	Lai
EAST (text search)	9/9/2009	Lai
EIC fast and focus search	2/18/10	Lai
Consulted Yves Dalencourt for allowable subject matters, search help	2/19/10	Lai
Consulted Moustafa Meky for allowable subject matters	2/20/10	Lai
EAST (text search)	8/6/10	Lai
Consulted Yves Dalencourt for allowable subject matters	8/10/10	Lai
NPL Multi-Search	8/11/10	Lai

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	238	8/11/10	Lai
Double Patenting		8/11/10	Lai

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